

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10564745	TAKAYAMA ET AL.
Examiner	Art Unit	
MICHAEL SZPERKA	1644	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
inventor search in eDAN: Takayama, Hiroshi; Shirakawa, Kamon; Yamakawa, Toru; kawahara, Tetsushi	6/4/08	MS
USPAT USPGPUB EPO JPO DERWENT (EAST) see search printouts	6/4/08	MS
MEDLINE AGRICOLA BIOSIS CAPLUS EMBASE SCISEARCH (STN) see search printouts	6/4/08	MS
STIC sequence search, see SCORE	6/4/08	MS

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner